

October 1987 Revised January 2004

CD4503BC

Hex Non-Inverting 3-STATE Buffer

General Description

The CD4503BC is a hex non-inverting 3-STATE buffer with high output current sink and source capability. 3-STATE outputs make it useful in bus-oriented applications. Two separate disable inputs are provided. Buffers 1 through 4 are controlled by the disable 4 input. Buffers 5 and 6 are controlled by the disable 2 input. A high level on either disable input will cause those gates on its control line to go into a high impedance state.

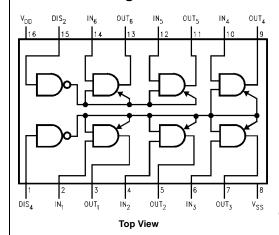
Features

- \blacksquare Wide supply voltage range: $\,$ 3.0 V_{DC} to 18 V_{DC}
- 3-STATE outputs
- Symmetrical turn on/turn off delays
- Symmetrical output rise and fall times
- Pin-for-pin replacement for MM80C97 and MC14503

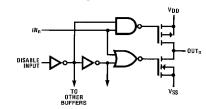
Ordering Code:

Order Number	Package Number	Package Description			
CD4503BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow			
CD4503BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide			

Connection Diagram



Schematic Diagram



Truth Table

In	Disable Input	Out
0	0	0
1	0	1
Х	1	3-STATE

X = Don't Care

Absolute Maximum Ratings(Note 1)

(Note 2)

Recommended Operating Conditions (Note 2)

Supply Voltage (V_{DD}) -0.5V to +18V

 $\label{eq:local_local_local_local_local_local} \begin{array}{ll} \mbox{Input Voltage (V_{IN})} & -0.5 \mbox{V to } +0.5 \mbox{V} \\ \mbox{Storage Temperature Range (T_S)} & -65 \mbox{^{\circ}C to } +150 \mbox{^{\circ}C} \end{array}$

Power Dissipation (P_D)

Dual-In-Line 700 mW Small Outline 500 mW

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C

Supply Voltage (V_{DD}) +3V to +15V Operating Temperature Range (T_{A}) -55°C to +125°C

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and "Electrical Characteristics" provide conditions for actual device operation.

Note 2: $V_{SS} = 0V$ unless otherwise specified.

DC Electrical Characteristics (Note 2)

Symbol	Parameter	Conditions	-5	–55°C		+25°C		+125°C		Units
			Min	Max	Min	Тур	Max	Min	Max	Jillis
I _{DD}	Quiescent Device	$V_{DD} = 5V$,		1			1		30	
	Current	$V_{IN} = V_{DD}$ or V_{SS}								
		V _{DD} = 10V,		2			2		60	μА
		$V_{IN} = V_{DD}$ or V_{SS}								μΑ
		V _{DD} = 15V,		4			4		120	
		$V_{IN} = V_{DD}$ or V_{SS}								
V _{OL}	LOW Level	$V_{IN} = V_{DD}$ or 0								
	Output Voltage	$V_{DD} = 5V$		0.05		0	0.05		0.05	
		$V_{DD} = 10V$		0.05		0	0.05		0.05	V
		V _{DD} = 15V		0.05		0	0.05		0.05	
V _{OH}	HIGH Level	V _{IN} = V _{DD} or 0								
	Output Voltage	$V_{DD} = 5V$	4.95		4.95	5		4.95		
		V _{DD} = 10V	9.95		9.95	10		9.95		V
		V _{DD} = 15V	14.95		14.95	15		14.95		
V _{IL}	LOW Level	$V_{DD} = 5V$,		1.5		2.25	1.5		1.5	
ıL	Input Voltage	V _O = 4.5V or 0.5V								
		V _{DD} = 10V,		3.0		4.50	3.0		3.0	
		V _O = 9.0V or 1.0V								V
		V _{DD} = 15V,		4.0		6.75	4.0		4.0	
		V _O = 13.5V or 1.5V								
V _{IH}	HIGH Level	V _{DD} = 5V,	3.5		3.5	2.75		3.5		
	Input Voltage	V _O = 0.5V or 4.5V								
		V _{DD} = 10V,	7.0		7.0	5.5		7.0		
		V _O = 1.0V or 9.0V								V
		V _{DD} = 15V,	11.0		11.0	8.25		11.0		
		V _O = 1.5V or 13.5V								
I _{OL}	LOW Level Output	V _{DD} = 4.5V, V _{OL} = 0.4V	2.8		2.3	2.55		1.60		
	Current	$V_{DD} = 5.0V, V_{OL} = 0.4V$	3.0		2.4	2.75		1.75		
		$V_{DD} = 10V, V_{OL} = 0.5V$	7.85		6.35	7.00		4.45		mA
		V _{DD} = 15V, V _{OL} = 1.5V	19.95		16.10	25.00		11.30		
Гон	HIGH Level Output	$V_{DD} = 5V, V_{OH} = 4.6V$	-1.28		-1.02	-1.76		-0.7		
	Current	$V_{DD} = 10V, V_{OH} = 9.5V$	-3.20		-2.60	-4.5		-1.8		mA
		$V_{DD} = 15V, V_{OH} = 13.5V$	-8.20		-6.80	-17.6		-4.8		
loz	3-STATE Leakage Current	V _{DD} = 15V		±0.1		±10 ⁻⁴	±0.1		±1.0	μА
I _{IN}	Input Current	V _{DD} = 15V		±0.1		±10 ⁻⁴	±0.1		±1.0	μΑ

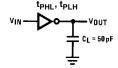
Note 3: I_{OH} and I_{OL} are tested one output at a time.

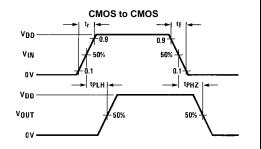
AC Electrical Characteristics (Note 4) $T_A = 25^{\circ}\text{C}, \ C_L = 50 \ \text{pF}, \ R_L = 200 \ \text{k}\Omega, \ \text{Input } t_r = t_f = 20 \ \text{ns}, \ \text{unless otherwise specified}$

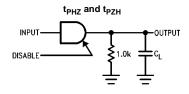
Symbol	Parameter	Conditions	Min	Тур	Max	Units
t _{PHL} , t _{PLH}	Propagation Delay Time	$V_{DD} = 5V$		75	100	
		$V_{DD} = 10V$		35	40	ns
		$V_{DD} = 15V$		25	30	
t _{PLZ} , t _{PHZ}	Propagation Delay Time,	$V_{DD} = 5V$		80	125	
	Logical Level to HIGH	$V_{DD} = 10V$		40	90	ns
	Impedance State	$V_{DD} = 15V$		35	70	
t _{PZL} , t _{PZH}	Propagation Delay Time,	$V_{DD} = 5V$		95	175	
	High Impedance State to	$V_{DD} = 10V$		40	80	ns
	Logical Level	$V_{DD} = 15V$		35	70	
t _{TLH}	Output Rise Time	$V_{DD} = 5V$		45	80	
		$V_{DD} = 10V$		23	40	ns
		$V_{DD} = 15V$		18	35	
t _{THL}	Output Fall Time	$V_{DD} = 5V$		45	80	
		$V_{DD} = 10V$		23	40	ns
		$V_{DD} = 15V$		18	35	

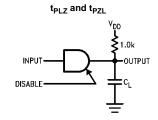
Note 4: AC Parameters are guaranteed by DC correlated testing.

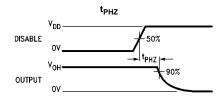
AC Test Circuits and Switching Time Waveforms

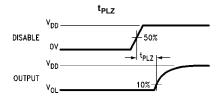


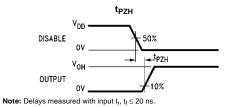


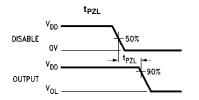




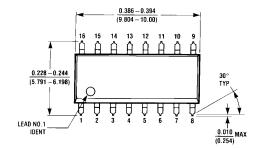


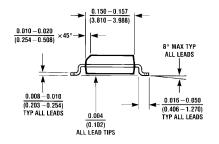


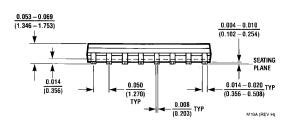




Physical Dimensions inches (millimeters) unless otherwise noted

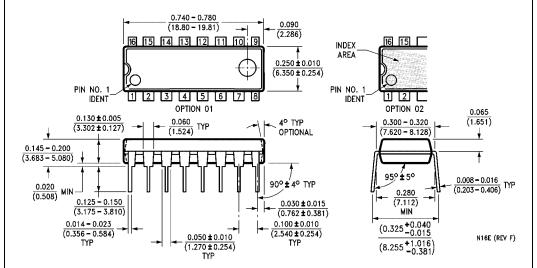






16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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